

Low-temperature behavior of NaGaSi₂O₆

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ABSTRACT

Synthetic NaGaSi₂O₆-pyroxene, space group *C2/c*, was investigated at low temperature between 295 to 110 K by X-ray diffraction. The evolution of the unit-cell parameters as a function of temperature does not indicate any structural phase transition down to 110 K. Calculated values for the Debye temperature, θ_D , and the Grüneisen parameter, γ , are 653(39) and 0.84(8) K, respectively, close to those of other pyroxenes. Five complete intensity data collections were performed at 295, 235, 190, 145, and 110 K to investigate the temperature dependence of the crystal structure. The space group remains *C2/c* down to 110 K, but anomalies were found between 235 and 190 K for the temperature dependencies of the volume and strain of the M1 polyhedron. This anomalous behavior could be related to variations of the Ga-O2(C1,D1) bond length and the O1(A1,B1)-Ga-O2(C1,D1) bond angle. The *C2/c-P1* phase transition observed in a previous work for NaTiSi₂O₆ at about 200 K did not occur for NaGaSi₂O₆ down to the minimum temperature investigated in this work. This is not due to the different ionic radius at M1 site or to a different tetrahedral chain extension between these two compositions but it is likely due to unfilled t_{2g} orbitals, which do not exist in NaGaSi₂O₆.

Keywords: Clinopyroxene, crystal structure, X-ray diffraction, low temperature

INTRODUCTION

Na-clinopyroxenes are among the most studied silicates because of their abundance in the Earth's lower-crust and upper mantle. They are major constituents of important high-pressure rocks (e.g., blueschists, eclogites) and are involved in several chemical reactions (e.g., NaAlSi₃O₈ = NaAlSi₂O₆ + SiO₂) crucial for the understanding of the Earth's constitution. Na-clinopyroxenes have the general chemical formula NaM³⁺Si₂O₆, with M = Al, Ga, In, Sc, Ti, V, Cr, Mn, and Fe, and space group *C2/c* at room conditions (Prewitt and Burnham 1966; Clark et al. 1969; Cameron et al. 1973; Hawthorne and Grundy 1974; Ohashi et al. 1982, 1983, 1987, 1990, 1994a, 1994b, 1995; Redhammer et al. 2003). The *C2/c* pyroxene crystal structure, which has been described in several previous works (see as a reference Yang and Prewitt 2000), is illustrated in Figure 1.

Several investigations have been performed on Na-pyroxenes as a function of temperature and pressure (Zhao et al. 1997; Redhammer and Roth 2002; Origlieri et al. 2003; Redhammer et al. 2003, 2006; Tribaudino et al. 2005; Nestola et al. 2006).

However, in spite of their simple crystal structures, some anomalous behavior is still to be clarified. It is, for instance, almost completely unknown whether a change of the electronic environment (e.g., changes in bond character, high-low spin transitions, crystal field effects) around the M1 site can affect significantly the pyroxene structure. It has been observed that some NaM³⁺Si₂O₆ clinopyroxenes with the same composition but synthesized under different conditions, show small but significant differences in densities and crystal structures at ambient conditions (NaTiSi₂O₆, Ohashi et al. 1982 and Redhammer et al. 2003; NaInSi₂O₆, Hawthorne and Grundy 1974 and Ohashi et al. 1990; NaGaSi₂O₆, Ohashi et al. 1983, 1995). Some authors have attributed such density variations to different electronic states of the M³⁺ ion (Ohashi et al. 1995). For instance, X-ray diffraction investigations at room temperature on a sample with Ga at the M1 site, NaGaSi₂O₆, showed the presence of two different structural configurations around the octahedral Ga³⁺ ion: Ga(α) and Ga(β) (Ohashi et al. 1983, 1995). NaGa(α)Si₂O₆ has a denser structure than NaGa(β)Si₂O₆ (3.91 and 3.89 Mg/m³, respectively) and a smaller M1 polyhedral volume [10.18(4) Å³ vs. 10.289(6) Å³]. The NaGa(α)Si₂O₆ compound has been quenched from high-pressures and temperatures more slowly than NaGa(β)Si₂O₆. It was assumed that the α and β forms represent two different polymorphs, possibly differing in the electronic state of the Ga-cation (Ohashi et al. 1995).

NaGaSi₂O₆ is not the only Ga-bearing compound showing

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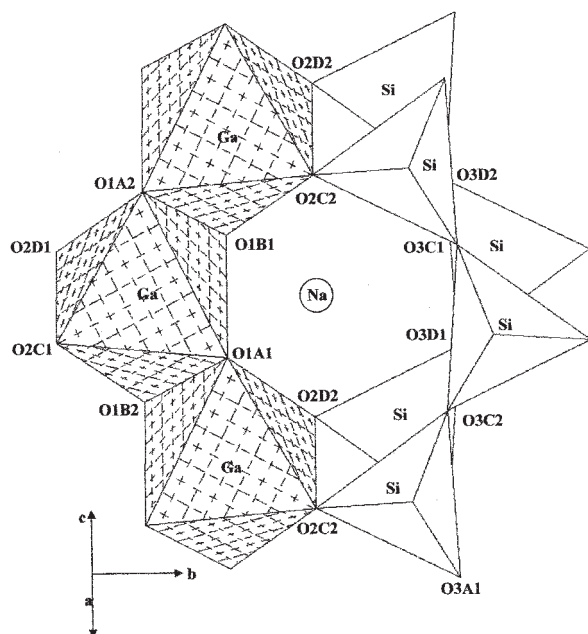


FIGURE 1. Projection of the structure of NaGaSi₂O₆ onto the (100) plane at room temperature. Atom labeling follows Clark et al. (1969).

anomalous behavior, as demonstrated by previous investigations on GaPO₄ (Sowa 1994) and La₃Ga₅SiO₁₄ (Werner et al. 2002). A recent investigation on PrGaO₃ (Vasylechko et al. 2005, orthorhombic with perovskite-type structure), using single-crystal X-ray diffraction, shows a yet unexplained change in slope in the Ga-Ga average distances between 200 and 300 K. The above anomalous behavior is revealed by very small structural variations, which might be hidden in the noise of less precise experiments. However, modern diffractometers allow us to determine such small differences, which were previously undetectable. Furthermore, with measurements at low temperature, the reduced thermal displacements permit resolution of very small structural variations.

In the present work we studied the thermal evolution of the crystal structure and unit-cell parameters of the low-density form of NaGaSi₂O₆ [Ga(β) pyroxene; the sample comes from the same batch of synthesis as previously studied by Ohashi et al. 1995] down to 110 K, to verify possible changes in the crystal structure at low temperatures. The study was performed with single-crystal X-ray diffraction methods using a rotating anode, which provides diffraction intensities up to ten times greater than those obtained with a conventional anode. The flexibility of the pyroxene silicate chain makes it possible to observe significant structural differences, even when the temperature range is small as in low-temperature investigations.

EXPERIMENTAL METHODS

The crystal was synthesized by solid-state reaction using a belt-type high-pressure apparatus (as in Ohashi et al. 1995). Mixtures of crystalline Na₂Si₂O₅, Ga₂O₃, and SiO₂ were sealed in platinum capsule and maintained at 1770 K and 6 GPa for 5 h. A crystal of size 120 × 80 × 70 μm³ was chosen for the low-temperature X-ray diffraction measurements. It showed sharp optical extinction and was tested

on a Huber four-circle diffractometer (non-monochromatic MoKα radiation) using the eight-position method of centering for 20 Bragg reflections according to the procedure of King and Finger (1979). No evidence of twinning was found. Centering procedure and vector-least-square refinement of the unit-cell parameters were performed by SINGLE04 software according to Ralph and Finger (1982) and Angel et al. (2000). The unit-cell parameters at room temperature were: $a = 9.5551(2)$ Å, $b = 8.7007(3)$ Å, $c = 5.2694(2)$ Å, $\beta = 107.626(2)^\circ$, $V = 417.51(2)$ Å³. X-ray diffraction at low temperatures was measured on a Nonius Mach3 diffractometer, equipped with a rotating anode using MoKα radiation ($\lambda = 0.71069$ Å). Unit-cell parameters were measured by centering 25 Bragg reflections within the range $43 < 2\theta < 60^\circ$ in four settings (SET4 procedure; Enraf-Nonius 1989). The unit-cell parameters at room temperature are in good agreement with those determined on the Huber diffractometer, in spite of the different experimental procedures [$a = 9.5531(3)$ Å, $b = 8.6983(2)$ Å, $c = 5.2684(1)$ Å, $\beta = 107.629(2)^\circ$, and $V = 417.22(2)$ Å³ for the MACH3 instrument].

Five complete intensity data collections were performed on the Nonius Mach3 diffractometer, at 295, 235, 190, 145, and 110 K, using ω - 2θ scans with a scan velocity between 1.3° and 4°/min up to $2\theta_{\max} = 80^\circ$. All intensity data were collected on the C-centered lattice, after checking for the presence of the C-centering down to 110 K (this monitoring was necessary because of the isostructural compound NaTiSi₂O₆ a phase transition to triclinic occurs at 197 K, Redhammer et al. 2003). Data reduction was performed using HELENA software (Spek 1997). Absorption correction was performed by HABITUS software (Herrendorf and Bärnighausen 1997), resulting in a strong improvement of the R_{int} . Structure refinements on F² were performed using SHELXL97 (Sheldrick 1997). X-ray scattering factors in their neutral form were taken from *International Table of Crystallography* (Wilson 1995). The crystal used for the low-temperature diffraction measurements was subsequently analyzed by electron microprobe using a fully automated four-spectrometer CAMECA SX-50 (acceleration voltage 15 kV; beam currents of 10–15 nA; focused electron beam of approximately 2 μm; internal correction routines of the instrument were used for data reduction and evaluation of elemental concentrations). The following compounds were used as standards: Si, Mg:MgSiO₃; Na:NaAlSi₃O₈; Ga:GaAs. The chemical formula based on an average of 15 point analyses confirmed the stoichiometric composition: Na_{1.00(1)}Ga_{1.01(1)}Si_{2.01(1)}O₆.

RESULTS

Thermal expansion

The unit-cell parameters have been determined at 14 selected temperatures from 295 down to 110 K (Table 1). Both the unit-cell parameters a , b , c , and the volume V of the unit cell decrease down to 110 K in a non-linear way, whereas the angle β remains constant at 107.63° within one standard deviation throughout the investigated range of temperatures. Unit-cell parameters exhibit a smooth dependence on temperature, and evidence for a possible structural phase transition is not found in these data (Fig. 2). Mean linear thermal expansion coefficients can be calculated as $\alpha_X(T) = (1/X_{295})[(X_T - X_{295})/(T - 295)]$, where X represents an unit-cell parameter and T is the temperature (Cameron et al. 1973). For $T = 110$ K they are: $\alpha_a(T) = 5.036(1) \times 10^{-6}$ K⁻¹, $\alpha_b(T) = 8.327(1) \times 10^{-6}$ K⁻¹, $\alpha_c(T) = 2.257(1) \times 10^{-6}$ K⁻¹. The mean thermal expansion coefficient for this temperature range is $\alpha_V(T) = 1.568(1) \times 10^{-5}$ K⁻¹. Thermal expansion is highly anisotropic, with $\alpha_a:\alpha_b:\alpha_c = 2.23:3.69:1$.

A suitable physical model for the thermal expansion of NaGaSi₂O₆ at low temperatures is provided by the Debye model for the density of states of phonons, resulting in the following relation between V and T (Suzuki et al. 1979):

$$V(T) = \frac{V_0}{2k} \left[1 + 2k - (1 - 4kE/Q_0)^{1/2} \right] \quad (1)$$

where E is the energy of the lattice vibrations, k is a constant, Q_0 is related to the volume (V_0) and bulk modulus (K_{T0}) at zero Kelvin and to the Grüneisen parameter (γ) by $Q_0 = K_0 V_0 / \gamma$. The

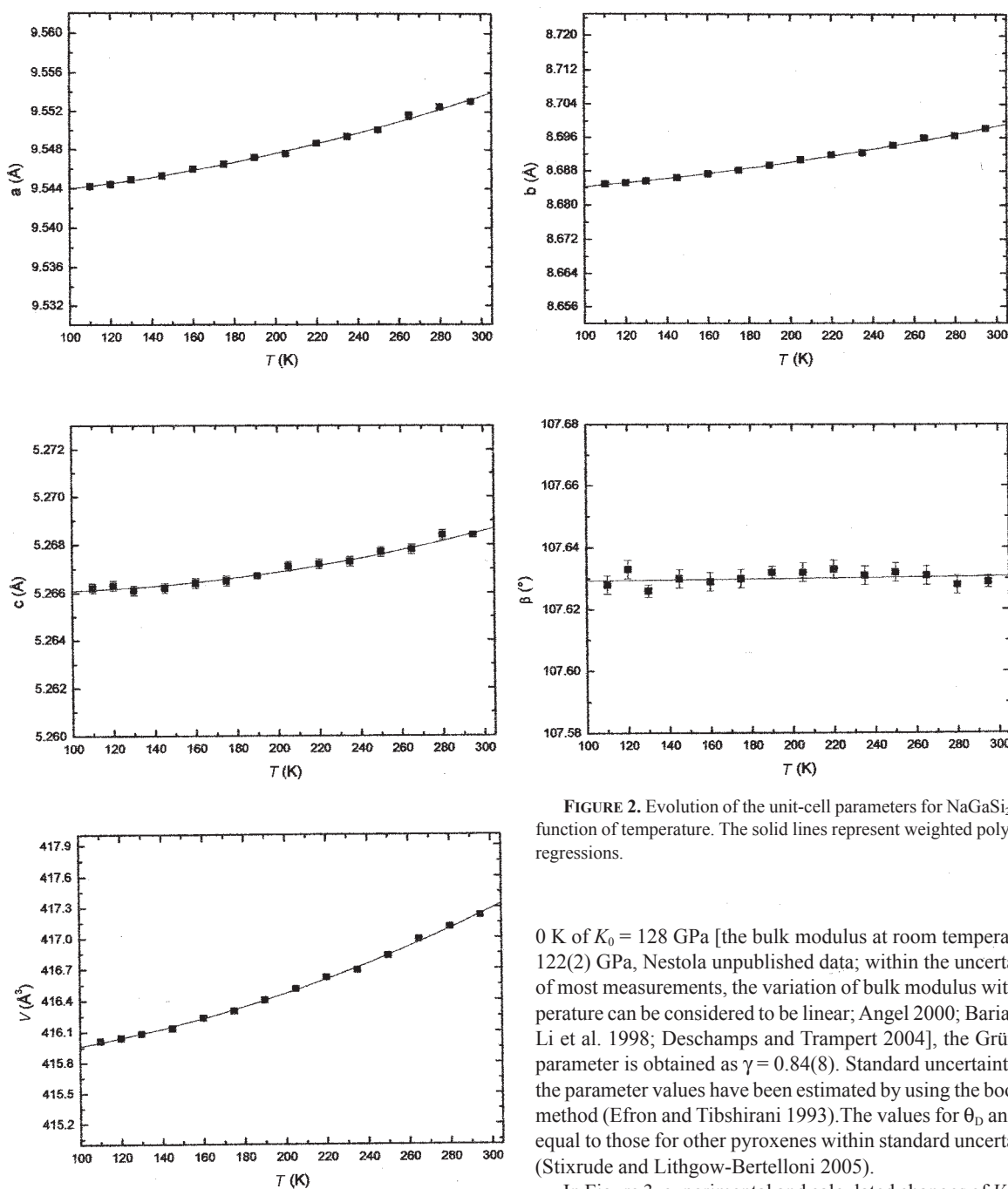


FIGURE 2. Evolution of the unit-cell parameters for NaGaSi₂O₆ as a function of temperature. The solid lines represent weighted polynomial regressions.

0 K of $K_0 = 128$ GPa [the bulk modulus at room temperature is 122(2) GPa, Nestola unpublished data; within the uncertainties of most measurements, the variation of bulk modulus with temperature can be considered to be linear; Angel 2000; Baria 2004; Li et al. 1998; Deschamps and Trampert 2004], the Grüneisen parameter is obtained as $\gamma = 0.84(8)$. Standard uncertainties for the parameter values have been estimated by using the bootstrap method (Efron and Tibshirani 1993). The values for θ_D and γ are equal to those for other pyroxenes within standard uncertainties (Stixrude and Lithgow-Bertelloni 2005).

In Figure 3, experimental and calculated changes of V with T are shown. The non-linear behavior at low T is well described, without systematic differences between the data and the model. The goodness of the fit excludes the possible presence of a phase transition. The thermal expansion coefficient as a function of T , α_V , is obtained by differentiating Equation 1 with respect to T , $\alpha_V = 1/V (\partial V/\partial T)_P$, and it is reported in Figure 4 (at 295 K, $\alpha_V = 2.180(1) \times 10^{-5} \text{ K}^{-1}$).

The isochoric heat capacity, C_V , which was calculated as a function of T/θ_D (obtained by deriving Equation 2 with respect to T , $C_V = (\partial V/\partial T)_P$, e.g., Kittel 1966) is reported in Figure 5. C_V is related to the isobaric heat capacity, C_P , by the equation C_P

energy E is calculated from the Debye model (e.g., Fei 1995; Kittel 1966):

$$E = \frac{9nRT}{(\theta_D/T)^3} \int_0^{\theta_D/T} \frac{x^3}{e^x - 1} dx \quad (2)$$

where n , R , and θ_D are the number of atoms in the chemical formula, the gas constant, and the Debye temperature, respectively.

The parameters obtained from a fit of Equation 1 to the data are: $V_0 = 415.91(5) \text{ \AA}^3$, $k = 8(4)$, $Q_0 = 9575(1149) \text{ kJ}$, and $\theta_D = 653(39) \text{ K}$. Furthermore, with an extrapolated bulk modulus at

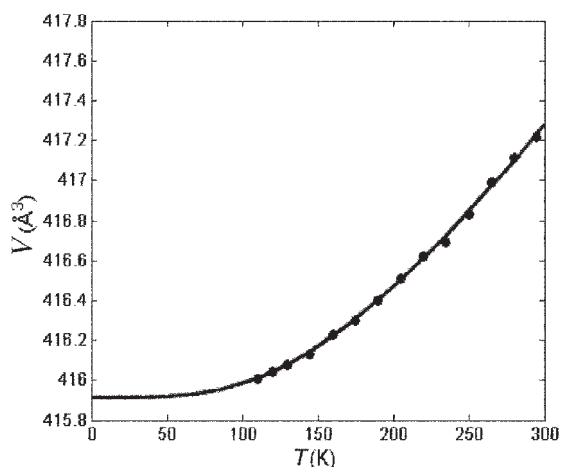


FIGURE 3. Experimental and calculated evolution of unit-cell volume with temperature for NaGaSi₂O₆.

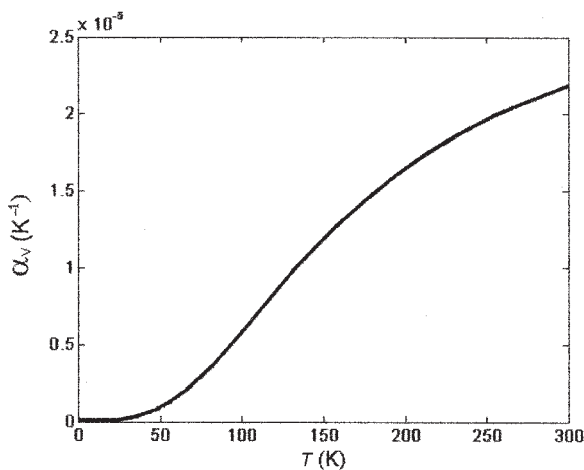


FIGURE 4. Thermal expansion coefficient, α_v , as a function of temperature for NaGaSi₂O₆. The curve displayed is a calculated curve according to a differentiation of Equation 1.

– $C_V = T\alpha_v^2 V_m K_T$, where V_m is the molar volume and K_T is the bulk modulus. The difference between C_p and C_V is relatively small and can be neglected, in particular below room temperature (given that $\alpha_v = 2.18 \times 10^{-5} \text{ K}^{-1}$, $V_m = 6.28 \text{ kJ/kbar}$ ($\approx 417 \text{ Å}^3$), $T = 298 \text{ K}$, and $K_T = 1220 \text{ kbar}$, ($C_p - C_V$) is $\approx 1 \times 10^{-3} \text{ kJ/mol}\cdot\text{K}$).

Temperature dependence of the crystal structure

Complete intensity data collections were carried out at five different temperatures: 295, 235, 190, 145, and 110 K. Structure refinements were performed, starting with the atomic coordinates of Ohashi et al. (1995). They confirmed the space group to be $C2/c$ down to 110 K. All the refinement and crystal data are reported in Table 2, whereas the refinement results (atomic fractional coordinates, displacement parameters, bond distances, angles, and polyhedral data) are reported in Tables 3 and 4.

M2 site

The polyhedral volume of M2, M1, and T sites and their standard deviations were calculated using IVTON software

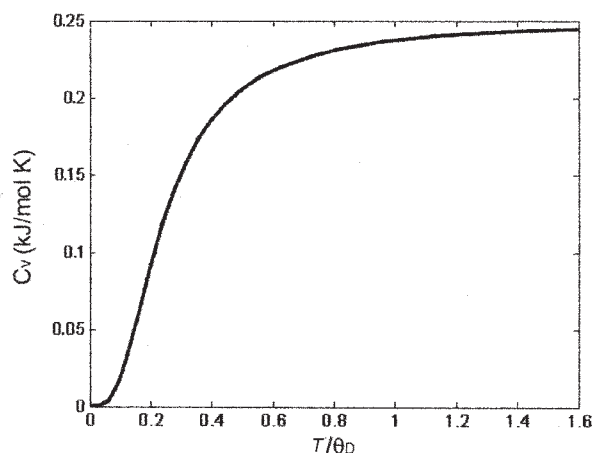


FIGURE 5. Isochoric heat capacity, C_V , as a function of T/θ_D for NaGaSi₂O₆.

TABLE 1. Unit-cell parameters of NaGaSi₂O₆ at different temperatures

Temperature (K)	<i>a</i> (Å)	<i>b</i> (Å)	<i>c</i> (Å)	β (°)	<i>V</i> (Å ³)
295	9.5531(3)	8.6983(2)	5.2684(1)	107.629(2)	417.22(2)
280	9.5525(3)	8.6965(2)	5.2684(2)	107.628(3)	417.11(2)
265	9.5516(4)	8.6960(2)	5.2678(2)	107.631(3)	416.99(2)
250	9.5501(3)	8.6942(2)	5.2677(2)	107.632(3)	416.83(2)
235	9.5494(3)	8.6924(2)	5.2673(2)	107.631(3)	416.69(2)
220	9.5487(3)	8.6919(2)	5.2672(2)	107.633(3)	416.62(2)
205	9.5476(3)	8.6907(2)	5.2671(2)	107.632(3)	416.51(2)
190	9.5472(3)	8.6894(2)	5.2667(1)	107.632(2)	416.40(2)
175	9.5465(3)	8.6882(2)	5.2665(2)	107.630(3)	416.30(2)
160	9.5460(3)	8.6873(2)	5.2664(2)	107.629(3)	416.23(2)
145	9.5453(3)	8.6864(2)	5.2662(2)	107.630(3)	416.13(2)
130	9.5449(3)	8.6856(2)	5.2661(2)	107.626(2)	416.08(2)
120	9.5444(3)	8.6852(2)	5.2663(2)	107.633(3)	416.04(2)
110	9.5442(3)	8.6849(2)	5.2662(2)	107.628(3)	416.01(2)

Note: One standard deviation is reported in parentheses.

(Balic-Zunic et al. 1996). The M2 volume at room temperature is 25.442(15) Å³ (Table 4) and shows a linear trend down to 110 K without discontinuities (Fig. 6a). It shrinks by 0.50% down to 110 K. As observed in general for clinopyroxenes, this polyhedron undergoes the strongest variations under non-ambient conditions. All the Na-O bond lengths in the irregular M2 polyhedron decrease with decreasing temperature (Table 4). The average bond length $\langle \text{Na-O} \rangle$ decreases linearly without discontinuities (Fig. 7a). The largest decrease is shown by the Na-O3(C2,D2) distances (the nomenclature used in this work is taken from Clark et al. 1969) with a variation of 0.29%, while the smallest decrease is for the Na-O3(C1; D1) distances, with a change of 0.11% with respect to the room temperature value (Figs. 8a and 8b). Na-O3(C1,D1), Na-O2(C2,D2), and Na-O3(C1,D1) bond distances do not show discontinuities in their temperature dependencies (Figs. 8a–8c), while the Na-O1(A1,B1) distances exhibit anomalies between 145 and 190 K (Fig. 8d).

M1 site

The octahedral volume of the M1 site is 10.289(6) Å³ at room temperature and decreases by 0.30% down to 110 K (Table 4). It shows an anomaly between 235 and 190 K, while it becomes independent of temperature at lower temperatures (Fig. 6b). The $\langle \text{Ga-O} \rangle$ average bond distance exhibits an anomaly within the

TABLE 2. Experimental crystal-structure details concerning the data collections and the structure refinements at different temperatures for NaGaSi₂O₆

	295 K	235 K	190 K	145 K	110 K
Crystal data					
Chemical formula	NaGaSi ₂ O ₆	NaGaSi ₂ O ₆	NaGaSi ₂ O ₆	NaGaSi ₂ O ₆	NaGaSi ₂ O ₆
<i>M_r</i>	244.88	244.88	244.88	244.88	244.88
<i>a</i> (Å)	9.5531(3)	9.5494(3)	9.5472(3)	9.5453(3)	9.5442(3)
<i>b</i> (Å)	8.6983(2)	8.6924(2)	8.6894(2)	8.6864(2)	8.6849(2)
<i>c</i> (Å)	5.2684(1)	5.2673(2)	5.2667(1)	5.2662(2)	5.2662(2)
β (°)	107.629(2)	107.631(3)	107.632(2)	107.630(3)	107.628(3)
<i>V</i> (Å ³)	417.22(2)	416.69(2)	416.40(2)	416.13(2)	416.01(2)
S.G.	C2/c	C2/c	C2/c	C2/c	C2/c
<i>Z</i>	4	4	4	4	4
<i>D_x</i> (Mg m ⁻³)	3.899	3.904	3.906	3.909	3.910
Radiation type	MoKα	MoKα	MoKα	MoKα	MoKα
No. refl. for the unit cell parameters	25	25	25	25	25
θ range for the unit cell parameters (°)	21.5–30	21.5–30	21.5–30	21.5–30	21.5–30
μ (mm ⁻¹)	7.22	7.23	7.23	7.24	7.24
Crystal form, color	Prismatic, light brown	Prismatic, light brown	Prismatic, light brown	Prismatic, light brown	Prismatic, light brown
Crystal size (mm)	0.120 × 0.08 × 0.07	0.120 × 0.08 × 0.07	0.120 × 0.08 × 0.07	0.120 × 0.08 × 0.07	0.120 × 0.08 × 0.07
Data collection					
Diffractionmeter	Nonius Mach3 (rotating anode)	Nonius Mach3 (rotating anode)	Nonius Mach3 (rotating anode)	Nonius Mach3 (rotating anode)	Nonius Mach3 (rotating anode)
Data coll. method	ω-2θ scan	ω-2θ scan	ω-2θ scan	ω-2θ scan	ω-2θ scan
Absorption correction	Habitus software	Habitus software	Habitus software	Habitus software	Habitus software
<i>T_{min}</i>	0.5348	0.5351	0.5355	0.5359	0.5362
<i>T_{max}</i>	0.7071	0.7071	0.7071	0.7071	0.7072
Range of <i>h, k, l</i>	-17 ≤ <i>h</i> ≤ 16 -15 ≤ <i>k</i> ≤ 15 0 ≤ <i>l</i> ≤ 9	-17 ≤ <i>h</i> ≤ 16 -15 ≤ <i>k</i> ≤ 15 0 ≤ <i>l</i> ≤ 9	-17 ≤ <i>h</i> ≤ 16 -15 ≤ <i>k</i> ≤ 15 0 ≤ <i>l</i> ≤ 9	-17 ≤ <i>h</i> ≤ 16 -15 ≤ <i>k</i> ≤ 15 0 ≤ <i>l</i> ≤ 9	-17 ≤ <i>h</i> ≤ 16 -15 ≤ <i>k</i> ≤ 15 0 ≤ <i>l</i> ≤ 9
No. of measured, independent and observed reflections	2779, 1291, 1186	2779, 1291, 1194	2778, 1291, 1195	2778, 1291, 1193	2777, 1291, 1196
Criterion for observed reflections	<i>I</i> > 4σ	<i>I</i> > 4σ	<i>I</i> > 4σ	<i>I</i> > 4σ	<i>I</i> > 4σ
<i>R_{int}</i>	0.020	0.017	0.016	0.018	0.016
θ _{max} (°)	39.96	39.94	39.95	39.96	39.96
Refinement					
Refinement on <i>R</i> [<i>F</i> ² > 4σ(<i>F</i> ²)], <i>wR</i> (<i>F</i> ²), <i>S</i>	0.0166, 0.046, 1.14	0.0156, 0.040, 0.99	0.0149, 0.043, 1.14	0.0154, 0.044, 1.15	0.0149, 0.042, 1.14
No. reflections	1186	1194	1195	1193	1196
No. parameters	48	48	48	48	48
Weighting scheme	1/[σ ² (<i>F_o</i> ²) + 0.0216 <i>P</i> ²]	1/[σ ² (<i>F_o</i> ²) + (0.0125 <i>P</i>) ² + <i>P</i>]	1/[σ ² (<i>F_o</i> ²) + (0.0171 <i>P</i>) ² + 0.27 <i>P</i>]	1/[σ ² (<i>F_o</i> ²) + (0.0178 <i>P</i>) ² + 0.19 <i>P</i>]	1/[σ ² (<i>F_o</i> ²) + (0.0171 <i>P</i>) ² + 0.27 <i>P</i>]
<i>P</i> = (<i>F_o</i> ² + <i>F_c</i> ²)/3					
(Δ/σ) _{max}	<0.0001	<0.0001	<0.0001	<0.0001	<0.0001
Δρ _{max} Δρ _{min} (e Å ⁻³)	0.59, -0.84	0.51, -0.47	0.48, -0.54	0.55, -0.48	0.46, -0.47
Extinction method	SHELXL	SHELXL	SHELXL	SHELXL	SHELXL
Extinction coefficient	0.0136	0.0124	0.0120	0.0128	0.0122

same range of temperatures (Fig. 7b). The largest variation for the Ga-O bond distances is shown by Ga-O1(A1,B1) (Fig. 9a) with a smooth decrease of up to 0.24% at 110K. Ga-O1(A2,B2) and Ga-O2(C1,D1) bond distances have small variations of 0.02% and 0.06%, respectively (Table 4), but they exhibit anomalies in their temperature dependencies (Figs. 9b and 9c). The three independent bond angles of the M1 octahedron, O1(A1,B1)-Ga-O1(A2,B2), O1(A1,B1)-Ga-O2(C1,D1), and O1(A2,B2)-Ga-O2(C1,D1), also exhibit anomalous behavior (Fig. 10), which gives an indication of the octahedral distortion.

T site

The tetrahedral polyhedron T for clinopyroxenes is considered a rigid unit showing always very small values of compressibilities and thermal expansion coefficients (Zhang et al. 1997; Angel and Hugh-Jones 1994; Nestola et al. 2004). This site is occupied by Si (Fig. 1) and has a volume of 2.197(2) Å³ at room temperature. As expected, its variation from room temperature down to 110 K is smaller than one standard deviation (Fig. 11a). The <Si-O> average bond distance does not show appreciable variations with temperature. The only Si-O bond distance,

showing a variation larger than one standard deviation, is the Si-O3A1 (Fig. 11b) with a very small non-linear expansion (about 0.10%). The evolution with temperature of the O3-O3-O3 angle, that defines the kinking of the tetrahedral silicate chain of the clinopyroxenes along *c*, shows a small but non-linear decrease on decreasing temperature, from 172.77(6)° at room temperature to 172.50(6)° at 110 K.

DISCUSSION

Thermal expansion

Anisotropic thermal expansion of Na pyroxenes is not completely characterized by the three linear expansion coefficients, because the angle β of the monoclinic lattice may also depend on temperature. Instead, the deformation has to be calculated from the unit-cell parameters at low and high temperatures, which can be described by the sizes and orientations of strain ellipsoids. The strain ellipsoid was calculated for NaGaSi₂O₆ using the software STRAIN (Ohashi 1982) from cell parameters at the highest and lowest temperatures (298 and 110 K), and by comparing cell parameters at Δ*T* intervals of about 60 K. The results are shown

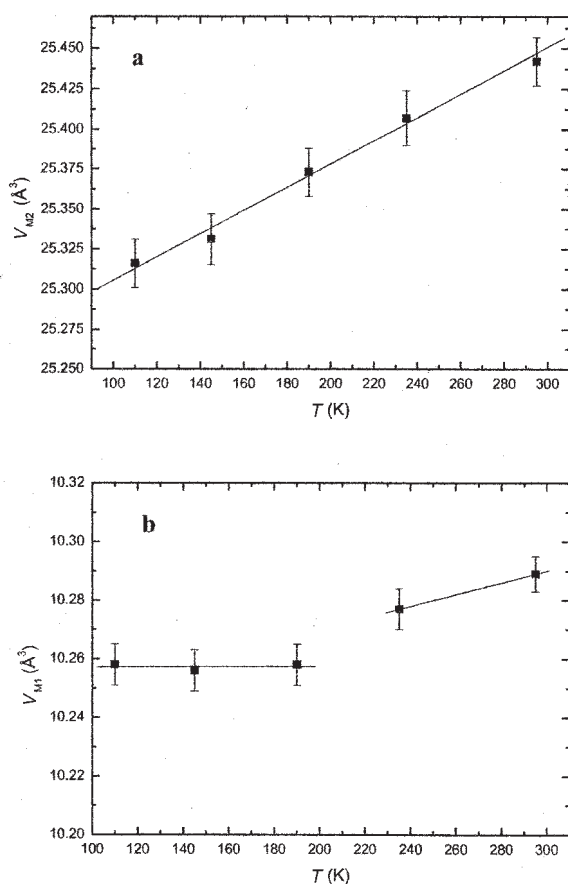


FIGURE 6. Polyhedral volume evolution as a function of temperature for the M2 polyhedron (a) and M1 octahedron (b) of NaGaSi₂O₆. The volumes and their standard deviations have been calculated using IVTON software (Balic-Zunic and Vickovic 1996).

in Table 5. The first principal axis lies along the monoclinic axis (**b** axis), and the orientation of the other two axes is similar for the different intervals. The deformation scheme is qualitatively the same as in other pyroxenes, with the largest deformation along the **b** axis. The orientations of the principal axes of the strain ellipsoid in the (010) plane vary with temperature. One principal axis is oriented about 100° from the **c** axis, as is also found in jadeite (NaAlSi₂O₆). In kosmochlor (NaCrSi₂O₆) and aegirine (NaFe³⁺Si₂O₆), this principal axis is located at 68° and 75°, respectively, from the **c** axis. (Table 5). This difference is probably related to the electronic structure of the M1 cation: in kosmochlor and aegirine M is a transition metal, whereas in the others it is not.

In summary, NaGaSi₂O₆ behaves similarly to other Na pyroxenes as far as the temperature dependences of the unit-cell parameters and the Debye temperature and the Grüneisen parameter are concerned.

Bonding behavior of NaGaSi₂O₆ at low temperature

We have investigated a sample of the low-density form NaGa(β)Si₂O₆ that has been suggested to be different than the high-density form NaGa(α)Si₂O₆ (Ohashi et al. 1983, 1995). The unit-cell parameters do not show any discontinuity in the

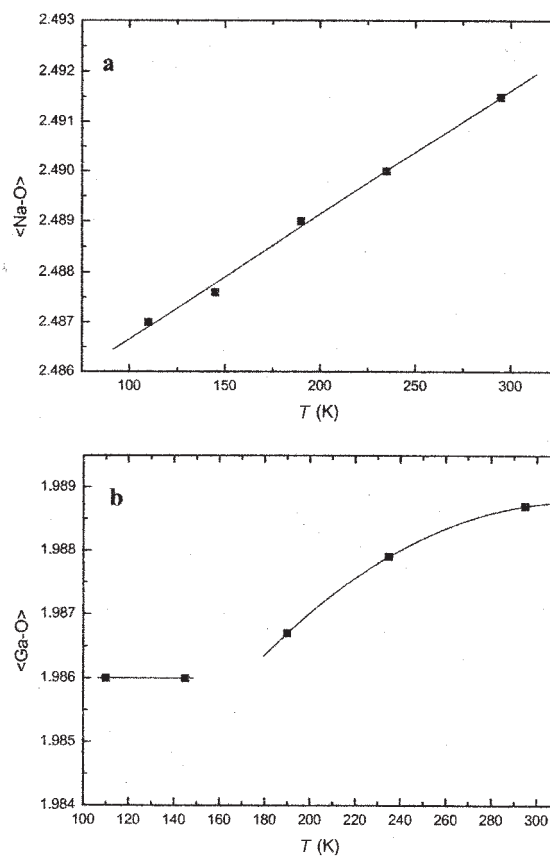


FIGURE 7. Evolution of Na-O (a) and Ga-O (b) average bond distances with temperature for NaGaSi₂O₆.

TABLE 3. Atomic fractional coordinates, equivalent isotropic, and anisotropic displacement parameters (Å²) at different temperatures for NaGaSi₂O₆.

		295 K	235 K	190 K	145 K	110 K
Na	x	0.00000	0.00000	0.00000	0.00000	0.00000
	y	0.30038(7)	0.30046(8)	0.30051(7)	0.30047(7)	0.30058(7)
	z	0.25000	0.25000	0.25000	0.25000	0.25000
	U _{eq}	0.0108(1)	0.0090(1)	0.0074(1)	0.0062(1)	0.0052(1)
Ga	x	0.00000	0.00000	0.00000	0.00000	0.00000
	y	0.90189(1)	0.90210(2)	0.90219(2)	0.90232(2)	0.90238(2)
	z	0.25000	0.25000	0.25000	0.25000	0.25000
	U _{eq}	0.00348(5)	0.00294(4)	0.00244(4)	0.00201(4)	0.00163(4)
Si	x	0.29116(3)	0.29119(3)	0.29119(3)	0.29121(3)	0.29125(3)
	y	0.09112(3)	0.09122(3)	0.09127(3)	0.09129(3)	0.09128(3)
	z	0.23220(5)	0.23236(5)	0.23241(5)	0.23263(5)	0.23264(5)
	U _{eq}	0.00314(5)	0.00274(5)	0.00237(5)	0.00206(5)	0.00183(5)
O1	x	0.11188(7)	0.11199(8)	0.11191(8)	0.11187(8)	0.11190(8)
	y	0.07804(7)	0.07797(8)	0.07803(7)	0.07812(8)	0.07820(7)
	z	0.13365(14)	0.13373(14)	0.13350(14)	0.13369(14)	0.13385(14)
	U _{eq}	0.0044(1)	0.0037(1)	0.0032(1)	0.0030(1)	0.00276(9)
O2	x	0.35874(8)	0.35868(8)	0.35878(8)	0.35880(8)	0.35882(8)
	y	0.25894(8)	0.25913(8)	0.25935(8)	0.25936(8)	0.25945(8)
	z	0.30170(14)	0.30187(15)	0.30219(14)	0.30240(14)	0.30267(14)
	U _{eq}	0.0062(1)	0.0053(1)	0.0046(1)	0.0039(1)	0.0034(1)
O3	x	0.35265(7)	0.35284(8)	0.35285(7)	0.35303(7)	0.35297(7)
	y	0.00957(9)	0.00984(9)	0.00980(8)	0.00986(8)	0.00994(8)
	z	1.00787(13)	1.00773(15)	1.00769(13)	1.00795(13)	1.00775(13)
	U _{eq}	0.0055(1)	0.0048(1)	0.0041(1)	0.0036(1)	0.0032(1)

Note: One standard deviation is reported in parentheses.

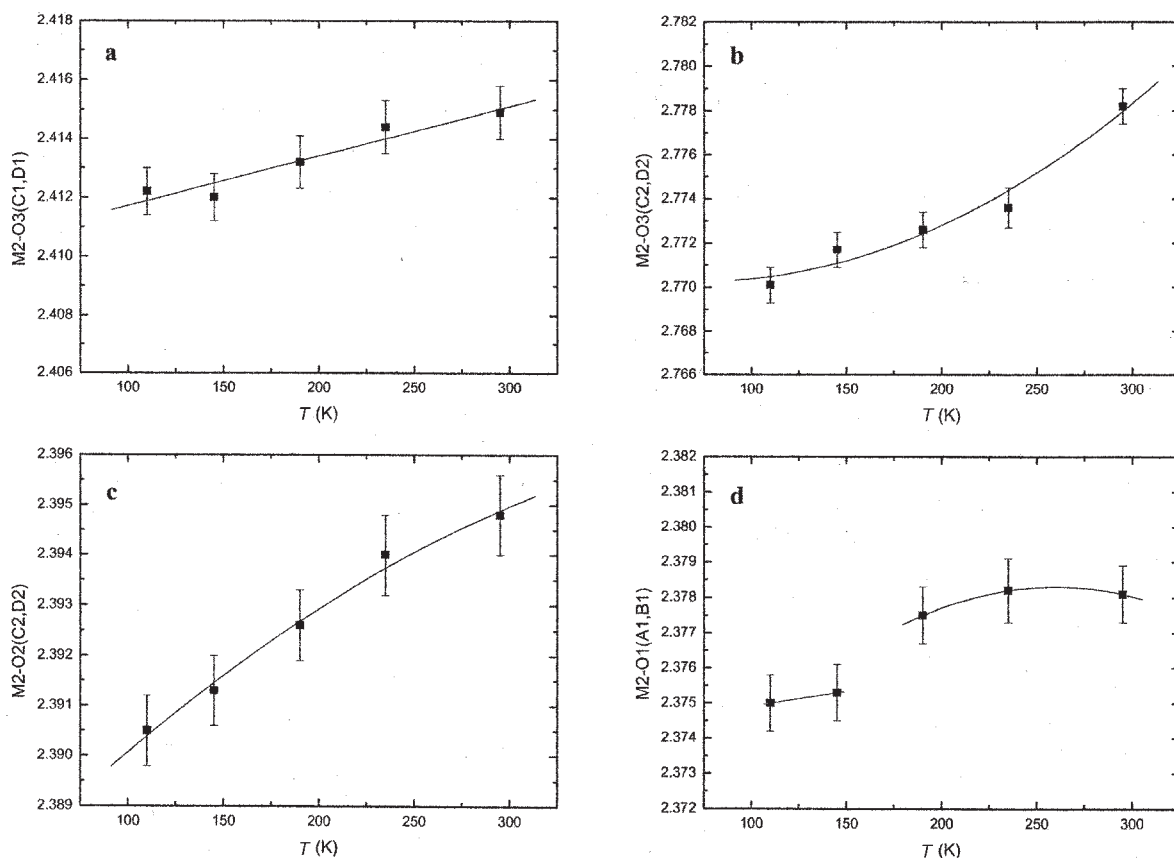


FIGURE 8. Bond distances evolution as a function of temperature for the M2 polyhedron: (a) Na-O3(C1,D1); (b) Na-O3(C2,D2); (c) Na-O2(C2,D2); (d) Na-O1(A1,B1).

TABLE 4. Selected bond lengths (Å), bond angles (°), and polyhedral volumes at different temperatures for NaGaSi₂O₆

Temperatures (K)	295	235	190	145	110
M2 polyhedron					
Na-O1(A1,B1)×2 (Å)	2.3781(8)	2.3782(9)	2.3775(8)	2.3753(8)	2.3750(8)
Na-O2(C2,D2)×2 (Å)	2.3948(8)	2.3940(8)	2.3926(7)	2.3913(7)	2.3905(7)
Na-O3(C1,D1)×2 (Å)	2.4149(9)	2.4144(9)	2.4132(9)	2.4120(8)	2.4122(8)
Na-O3(C2,D2)×2 (Å)	2.7782(8)	2.7736(9)	2.7726(8)	2.7717(8)	2.7701(8)
<Na-O> (Å)	2.492(2)	2.490(2)	2.489(2)	2.488(2)	2.487(2)
V _{M2} (Å ³)	25.442(15)	25.407(17)	25.373(15)	25.331(16)	25.316(15)
M1 octahedron					
Ga-O1(A1,B1)×2 (Å)	2.0646(7)	2.0622(7)	2.0615(7)	2.0600(7)	2.0596(7)
Ga-O1(A2,B2)×2 (Å)	1.9874(7)	1.9874(7)	1.9858(7)	1.9862(7)	1.9869(7)
Ga-O2(C1,D1)×2 (Å)	1.9142(7)	1.9141(7)	1.9127(7)	1.9131(7)	1.9131(7)
<Ga-O> (Å)	1.989(2)	1.988(2)	1.987(2)	1.986(2)	1.986(2)
V _{M1} (Å ³)	10.289(6)	10.277(7)	10.258(7)	10.256(7)	10.258(7)
*OAV	43.387	43.069	43.155	42.858	42.646
Bond angles (°)					
O1(A1,B1)-Ga-O1(A2,B2) (°)	93.98(3)	94.00(3)	94.06(3)	94.11(3)	94.12(3)
O1(A1,B1)-Ga-O2(C1,D1) (°)	89.38(3)	89.28(3)	89.24(3)	89.26(3)	89.24(3)
O1(A2,B2)-Ga-O2(C1,D1) (°)	90.95(3)	90.93(3)	90.96(3)	90.98(3)	91.00(3)
T tetrahedron					
Si-O1 (Å)	1.6362(7)	1.6349(8)	1.6352(7)	1.6354(7)	1.6353(7)
Si-O2 (Å)	1.5933(7)	1.5927(8)	1.5940(7)	1.5934(7)	1.5940(7)
Si-O3A1 (Å)	1.6327(7)	1.6336(8)	1.6342(7)	1.6344(7)	1.6344(7)
Si-O3A2 (Å)	1.6446(7)	1.6446(8)	1.6440(7)	1.6444(7)	1.6437(7)
<Si-O> (Å)	1.627(1)	1.626(1)	1.627(1)	1.627(1)	1.627(1)
V _T (Å ³)	2.197(2)	2.197(2)	2.198(2)	2.198(2)	2.198(2)
Kinking of tetrahedral chain O3-O3-O3 (°)					
	172.77(6)	172.60(6)	172.55(6)	172.64(6)	172.50(6)

Note: In parentheses, one standard deviation is reported.

* Octahedral angle variance as in Robinson et al. (1971).

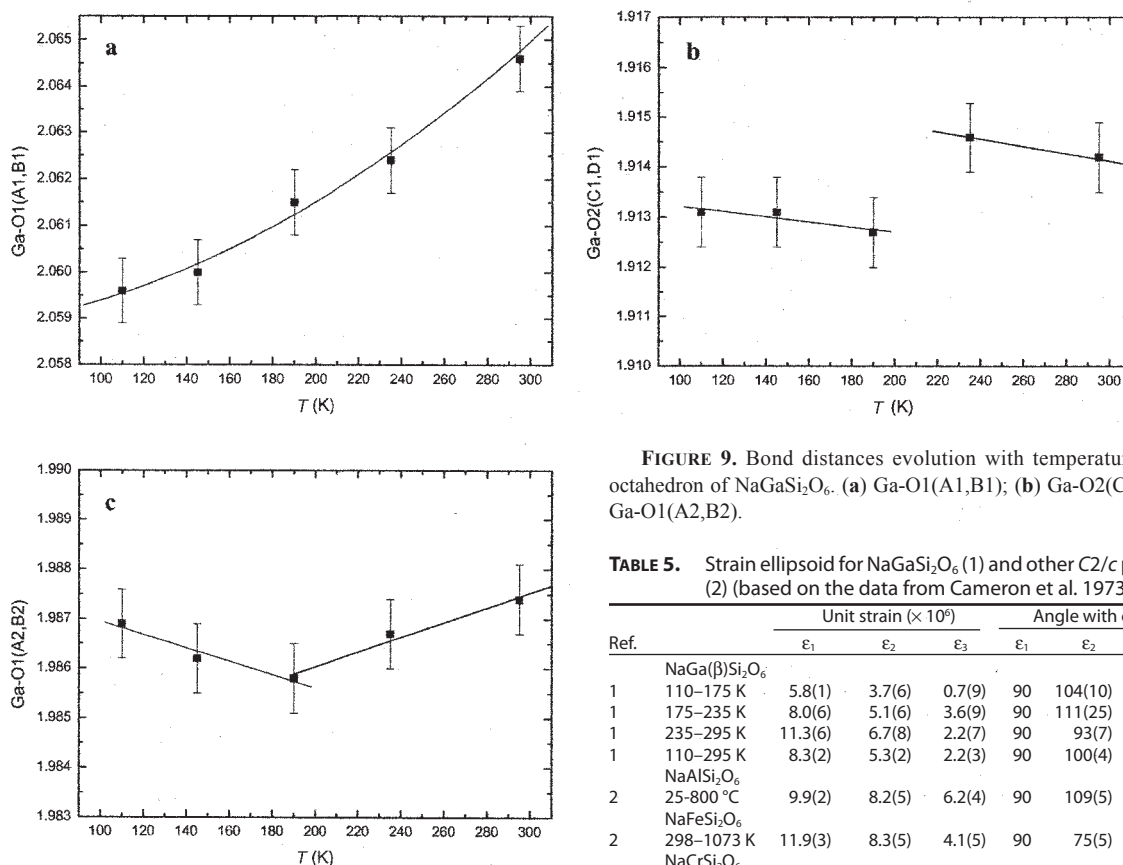


FIGURE 9. Bond distances evolution with temperature for M2 octahedron of NaGaSi₂O₆. (a) Ga-O1(A1,B1); (b) Ga-O2(C1,D1); (c) Ga-O1(A2,B2).

TABLE 5. Strain ellipsoid for NaGaSi₂O₆ (1) and other C2/c pyroxenes (2) (based on the data from Cameron et al. 1973)

Ref.		Unit strain ($\times 10^6$)			Angle with c ($^\circ$)		
		ϵ_1	ϵ_2	ϵ_3	ϵ_1	ϵ_2	ϵ_3
1	NaGa(β)Si ₂ O ₆						
	110–175 K	5.8(1)	3.7(6)	0.7(9)	90	104(10)	14(10)
	175–235 K	8.0(6)	5.1(6)	3.6(9)	90	111(25)	22(25)
	235–295 K	11.3(6)	6.7(8)	2.2(7)	90	93(7)	3(7)
	110–295 K	8.3(2)	5.3(2)	2.2(3)	90	100(4)	10(4)
2	NaAlSi ₂ O ₆						
	25–800 °C	9.9(2)	8.2(5)	6.2(4)	90	109(5)	19(5)
2	NaFeSi ₂ O ₆						
	298–1073 K	11.9(3)	8.3(5)	4.1(5)	90	75(5)	–15(5)
2	NaCrSi ₂ O ₆						
	298–873 K	9.6(3)	7.7(4)	3.4(4)	90	68(4)	–22(4)

investigated range of temperatures and no evidence of a structural phase transition was found.

As a first result, NaGaSi₂O₆ does not show the C2/c- $P\bar{1}$ phase transition found in the isostructural NaTiSi₂O₆ at 200 K (Redhammer et al. 2003). This would indicate that the substitution of a smaller cation as Ga for Ti at the M1 site (ionic radii are 0.67 Å for Ti and 0.62 Å for Ga, Shannon 1976) would stabilize the higher symmetry phase, increasing the stability field of the C2/c space group toward lower temperatures. However, NaFeSi₂O₆ pyroxene, which has a M1 cation radius very close to that of NaTiSi₂O₆ (Fe³⁺ = 0.645 Å, Shannon 1976), does not show any symmetry change down to 30 K (Redhammer and Roth 2002), assuming that the monoclinic-triclinic phase transition for Na clinopyroxenes is related to the M1 cation radius. Also for Li-bearing clinopyroxenes (LiM³⁺Si₂O₆ with M³⁺ = Cr, Ga, Sc, V, Al, In) a phase transition P2₁/c-C2/c occurs at low temperature but it is not simply related to a change in cationic radius at M1 site, as shown by Redhammer and Roth 2004. These authors suggested that a key role in the transformation is represented by the extension of the tetrahedral chain (O3–O3–O3 angle). Samples with nearly fully extended tetrahedral chains (O3–O3–O3 angle close 180°) at ambient conditions undergo phase transitions at low temperatures, while those with chains more kinked do not show a phase transition. However, for the monoclinic-triclinic phase transition in Na-bearing clinopyroxenes the relation between the

change in symmetry and the extension of the tetrahedral chain is not apparent: NaTiSi₂O₆ clinopyroxene (Redhammer et al. 2003) with a tetrahedral chain showing a kinking angle of about 174° has a phase transition at about 200 K, whereas NaFeSi₂O₆ with an almost identical kinking angle of 174.2° does not show any transformation down to 30 K (Redhammer and Roth 2002). Furthermore, as shown in this study, NaGaSi₂O₆ with a kink angle of 172.77° does not show a phase transformation down to 110 K. It can therefore be concluded that possible phase transitions of Na-bearing clinopyroxenes are not related to the radii of the M cations or to the extension of the tetrahedral chain. As suggested by Redhammer et al. (2003), principal differences between pyroxenes are related to the electronic configurations of the M1 cations. Some compounds containing transition elements do show phase transitions, while it seems that compounds without transition elements do not exhibit phase transitions. For pyroxenes containing 3d transition elements at M1 site, the nature of the low-temperature phase transition could be related to the 3d electron shell as shown by Redhammer et al. (2003). Their plot of M1–M1 distances vs. M1–O mean bond distances indicates that pyroxenes with a symmetric 3d electron shell (e.g., NaFeSi₂O₆, NaGaSi₂O₆, and NaAlSi₂O₆) lie on the same linear trend and do not show a low-temperature phase transition. In contrast, pyroxenes with an asymmetrical 3d electron shell (e.g., NaTiSi₂O₆) lie outside this trend and undergo a phase transition at

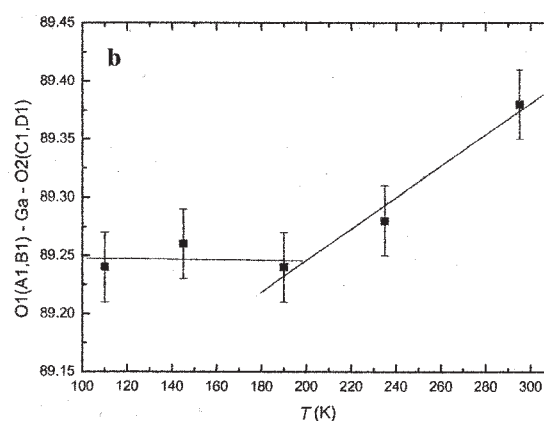
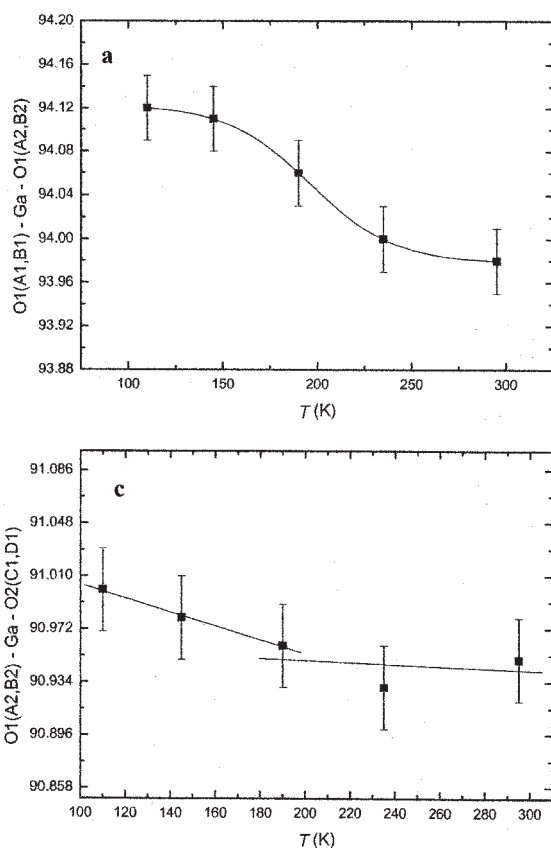


FIGURE 10. Evolution as a function of temperature of the three independent bond angles (a) O1(A1,B1)-Ga-O1(A2,B2), (b) O1(A1,B1)-Ga-O2(C1,D1), and (c) O1(A2,B2)-Ga-O2(C1,D1) for NaGaSi₂O₆.

low temperature. Unfortunately, it is not possible to demonstrate such a hypothesis because there are no data for samples such as NaCrSi₂O₆, NaVSi₂O₆, and NaMnSi₂O₆, which also lie outside the M1-M1 vs. M1-O trend. X-ray diffraction experiments on such samples are in progress at low temperature to verify the presence of low-temperature triclinic symmetry.

Anomalies in their temperature dependencies have presently been found for several structural parameters of NaGaSi₂O₆, in particular the volume, bond lengths, and strain deformation of the M1 octahedron (Figs. 6, 9, and 10). The observed anomalies are, however, not related to a transformation from NaGa(β)Si₂O₆ to NaGa(α)Si₂O₆ as proposed by Ohashi et al. (1995) for the following reasons: (1) the average M1-O bond length extrapolated up to room temperature from the two values at lowest temperatures has a value of 1.986 Å; this value is closer to that of NaGa(β)Si₂O₆ (1.989 Å) than that of NaGa(α)Si₂O₆ (1.982 Å) at room temperature. (2) The Ga-O1(A2,B2) bond length is found at all temperatures to be longer than 1.986 Å, which is the value at room temperature for NaGa(β)Si₂O₆. The corresponding bond length in NaGa(α)Si₂O₆ is 1.973 Å. (3) The octahedral angle (Table 4, OAV, Robinson et al. 1971) for the M1 polyhedron shows values between 42.6° (at 110 K) and 43.4° (at 295 K); such values are quite different from the OAV of 46.0° at room temperature in NaGa(α)Si₂O₆.

A possible explanation for the discontinuities in the shape of the M1 polyhedron is that of an isostructural rearrangement, involving the Ga-O polyhedral bond distances and angles. Analysis

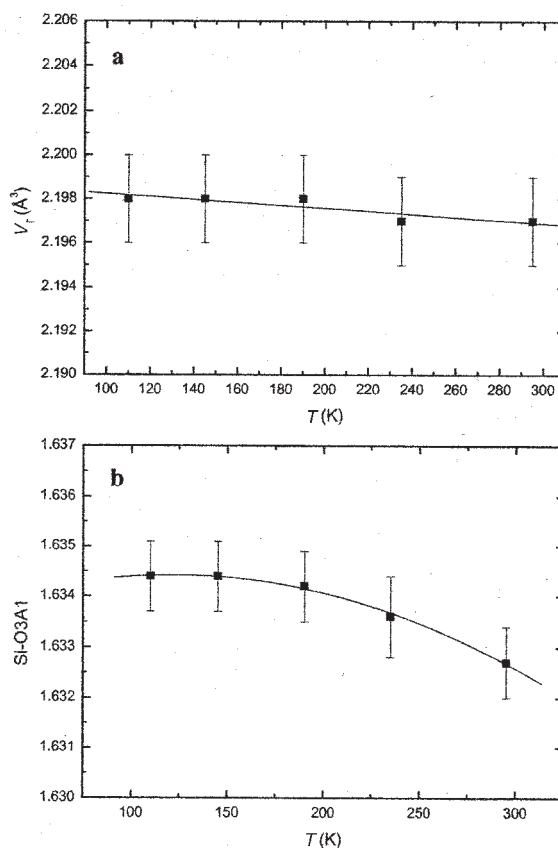


FIGURE 11. Tetrahedral volume evolution as a function of (a) temperature and (b) variation of Si-O3A1 bond distance down to 110 K for NaGaSi₂O₆. The volume and its standard deviation has been calculated using IVTON software (Balic-Zunic and Vickovic 1996).

of the electron configuration via an initio Hartree-Fock methods is currently under investigation to clarify this issue.

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